	Application No.	Applicant(s)
Notice of Allowability	10/073,171 Examiner	SPINK, ROGER Art Unit
		2070
	Davienne Monbleau	2878
The MAILING DATE of this communication appeal All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85; NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT R of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this or other appropriate communicat IGHTS. This application is subjection.	application. If not included tion will be mailed in due course. THIS
1. \boxtimes This communication is responsive to <u>the Amendment filed</u>	11/5/04 and the attached Examin	ner's Amendment.
2. The allowed claim(s) is/are 1-22 and 27-33.		
3. A The drawings filed on <u>05 June 2002</u> are accepted by the E	Examiner.	
 4. Acknowledgment is made of a claim for foreign priority una) All b) Some* c) None of the: Certified copies of the priority documents have Certified copies of the priority documents have Copies of the certified copies of the priority documents have Copies of the certified copies of the priority do International Bureau (PCT Rule 17.2(a)). * Certified copies not received: 	e been received. e been received in Application No.	•
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONN THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.	of this communication to file a rep MENT of this application.	oly complying with the requirements
5. A SUBSTITUTE OATH OR DECLARATION must be subm INFORMAL PATENT APPLICATION (PTO-152) which give	nitted. Note the attached EXAMINI es reason(s) why the oath or decla	ER'S AMENDMENT or NOTICE OF aration is deficient.
6. CORRECTED DRAWINGS (as "replacement sheets") must (a) including changes required by the Notice of Draftspers 1) hereto or 2) to Paper No./Mail Date (b) including changes required by the attached Examiner Paper No./Mail Date Identifying indicia such as the application number (see 37 CFR 1 each sheet. Replacement sheet(s) should be labeled as such in the sheet in the shee	son's Patent Drawing Review (PT . s Amendment / Comment or in the .84(c)) should be written on the dra	e Office action of
 DEPOSIT OF and/or INFORMATION about the depo attached Examiner's comment regarding REQUIREMENT 	sit of BIOLOGICAL MATERIA	L must be submitted. Note the
Attachment(s) 1. ☐ Notice of References Cited (PTO-892) 2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948) 3. ☑ Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date 11/5/04 4. ☐ Examiner's Comment Regarding Requirement for Deposit of Biological Material	6. ⊠ Interview Summa Paper No./Mail I 08), 7. ⊠ Examiner's Amer	Date <u>12/13/04</u> .

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EXAMINER'S COMMENT AND STATEMENT OF REASONS FOR ALLOWANCE

Information Disclosure Statement

The IDS filed on 11/5/04 has been acknowledged and a signed copy of the PTO-1449 is attached herein.

Response to Amendment

The amendment filed on 11/5/04 has bee entered. Claims 1, 5, 14, 15 17-19 and 21 have been amended. New Claims 23-33 have been added. Claims 1-33 are pending.

Applicant's arguments filed on 11/5/04 have been carefully considered and found persuasive in light of the corresponding amendments.

In particular, Applicant argues on page 10 that the cited prior art of record (*Leblans*) does not teach or suggest "an image sensor analysis unit [that] is adapted to detect image changes in distinct regions of a specimen over time." Examiner held that *Leblans* did teach this limitation in the "Description of the Related Art." (*Leblans* page 1 [0006]). "When the observed object is larger than the field of view of the microscope, the microscope can only focus on the portion of the object that can be observed through the field of view of the microscope." This requires that the objective move in a direction perpendicular to its optical axis to observe the distinct regions. However, *Leblans* teaches away from this structure because it requires that "the focusing conditions must be regularly checked and adjusted in order to maintain a sharp image of the whole object." *Leblans*, on the other hand, teaches autofocusing detection by determining the amount of displacement of the image of the object plane in the optical system from a desired focused reference plane based on the detected displacement of an image plane of the reflected autofocusing light beam from a predetermined reference plane in the autofocusing detection

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system." (Leblans page 2 [0014]). Leblans does not teach detecting image changes in distinct regions of the specimen over time.

Accordingly, the incorporated Examiner's amendment for Claim 27 further clarifies that the objective is moved along its optical axis, not perpendicular to its optical path, which would be required to view distinct regions as taught in the background art. (See Examiner's Amendment below).

Examiner's Amendment

An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Authorization for this examiner's amendment was given in a telephone interview with Frederick Tenney on 12/13/04.

The application has been amended as follows:

Claims 23-26: CANCEL

Claim 27 line 6: insert -- along an optical axis of the objective -- after "automatically moved."

Claim 27 line 7: insert -- along the optical axis of the objective -- after "corresponding to a."

Allowable Subject Matter

Claims 1-22 and 27-33 are allowed in light of the corresponding amendments.

The following is an examiner's statement of reasons for allowance:

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Regarding Claims 1-18, the cited prior art of record does not teach or fairly suggest a method for autofocusing the objective of an optical device onto a target region of a specimen comprising, along with the other claimed features, determining image changes for each of the plurality of regions of the specimen and defining as the target region the region among the plurality of regions of the specimen which exhibits a predetermined image change value.

Regarding Claims 19-22 and 27-33, the cited prior art of record does not teach or fairly suggest an apparatus for automatically focusing an optical system comprising, along with the other claimed features, an image sensor that is adapted to detect image changes in distinct regions of the specimen over time.

The advantages of these features are in the specification on pages 1-4. In particular, these features permit a user to focus on a distinct region of a specimen without have to move the objective to a different field of view.

Conclusion

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Davienne Monbleau whose telephone number is 571-272-1945. The examiner can normally be reached on Mon-Fri 9:00 am to 5:00 pm.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Dave Porta can be reached on 571-272-2444. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

arienne Menbleau

DNM

DAVID PORTA SUPERVISORY PATENT EXAMINER **TECHNOLOGY CENTER 2800**